- **Inputs Are TTL-Voltage Compatible**
- **Flow-Through Architecture Optimizes PCB Layout**
- **Center-Pin V$_{CC}$ and GND Configurations Minimize High-Speed Switching Noise**
- *EPIC*™ **(Enhanced-Performance Implanted CMOS) 1-μm Process**
- **500-mA Typical Latch-Up Immunity at 125°C**
- **Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs**

D OR N PACKAGE
(TOP VIEW)

```
        _____
1A  [ 1        16 ]  1B
1Y  [ 2        15 ]  2A
2Y  [ 3        14 ]  2B
GND [ 4        13 ]  VCC
GND [ 5        12 ]  VCC
3Y  [ 6        11 ]  3A
4Y  [ 7        10 ]  3B
4B  [ 8         9 ]  4A
        _____
```
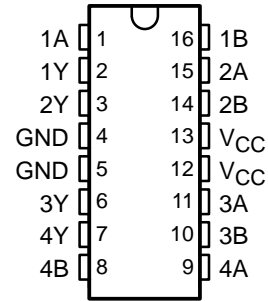
description

This device contains four independent 2-input exclusive-OR gates. They perform the Boolean functions $Y = A \oplus B = \overline{A}B + A\overline{B}$ in positive logic.
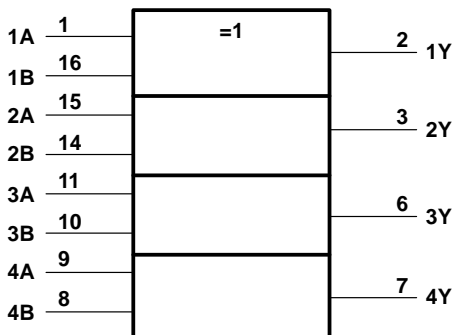
A common application is as a true/complement element. If one of the inputs is low, the other input will be reproduced in true form at the output. If one of the inputs is high, the signal on the other input will be reproduced inverted at the output.

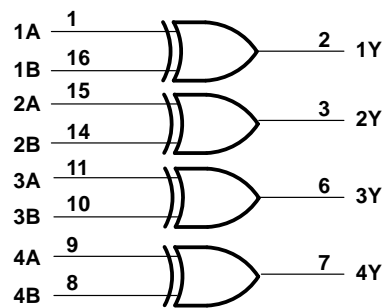The 74ACT11086 is characterized for operation from – 40°C to 85°C.

FUNCTION TABLE

INPUTS		OUTPUT
A	**B**	**Y**
L	L	L
L	H	H
H	L	H
H	H	L

logic symbol†

logic diagram (positive logic)

† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

TEXAS INSTRUMENTS

POST OFFICE BOX 655303 ● DALLAS, TEXAS 75265

74ACT11086
QUADRUPLE 2-INPUT EXCLUSIVE-OR GATE

exclusive-OR logic

An exclusive-OR gate has many applications, some of which can be represented better by alternative logic symbols.
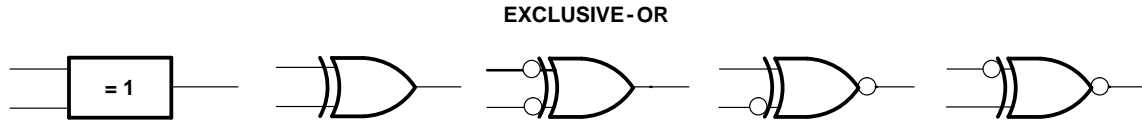
EXCLUSIVE-OR

These are five equivalent exclusive-OR symbols valid for an ′HC86 gate in positive logic; negation may be shown at any two ports.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} .... −0.5 V to 7 V
Input voltage range, V_I (see Note 1) .... −0.5 V to V_{CC} + 0.5 V
Output voltage range, V_O (see Note 1) .... −0.5 V to V_{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) .... ± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) .... ± 50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC}) .... ± 50 mA
Continuous current through V_{CC} or GND .... ± 100 mA
Storage temperature range .... −65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

		MIN	MAX	UNIT
V_{CC}	Supply voltage	4.5	5.5	V
V_{IH}	High-level input voltage		2	V
V_{IL}	Low-level input voltage		0.8	V
V_I	Input voltage	0	V_{CC}	V
V_O	Output voltage	0	V_{CC}	V
I_{OH}	High-level output current		−24	mA
I_{OL}	Low-level output current		24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
T_A	Operating free-air temperature	−40	85	°C

TEXAS INSTRUMENTS

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V_{CC}	$T_A = 25°C$			MIN	MAX	UNIT
				MIN	TYP	MAX			
V_{OH}	$I_{OH} = -50\ \mu A$		4.5 V	4.4			4.4		V
			5.5 V	5.4			5.4		
	$I_{OH} = -24\ mA$		4.5 V	3.94			3.8		
			5.5 V	4.94			4.8		
	$I_{OH} = -75\ mA$†		5.5 V				3.85		
V_{OL}	$I_{OL} = 50\ \mu A$		4.5 V			0.1		0.1	V
			5.5 V			0.1		0.1	
	$I_{OL} = 24\ mA$		4.5 V			0.36		0.44	
			5.5 V			0.36		0.44	
	$I_{OL} = 75\ mA$†		5.5 V					1.65	
I_I	$V_I = V_{CC}$ or GND		5.5 V			± 0.1		± 1	μA
I_{CC}	$V_I = V_{CC}$ or GND,	$I_O = 0$	5.5 V			4		40	μA
ΔI_{CC}‡	One input at 3.4 V,	Other inputs at GND or V_{CC}	5.5 V			0.9		1	mA
C_i	$V_I = V_{CC}$ or GND		5 V		3.5				pF

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.
‡ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25°C$			MIN	MAX	UNIT
			MIN	TYP	MAX			
t_{PLH}	A or B	Y	1.5	5.1	8.7	1.5	9.6	ns
t_{PHL}			1.5	5.1	8	1.5	9	

operating characteristics, $V_{CC} = 5\ V$, $T_A = 25°C$

PARAMETER		TEST CONDITIONS		TYP	UNIT
C_{pd}	Power dissipation capacitance per gate	$C_L = 50\ pF$,	f = 1 MHz	26	pF

PARAMETER MEASUREMENT INFORMATION

LOAD CIRCUIT

VOLTAGE WAVEFORMS
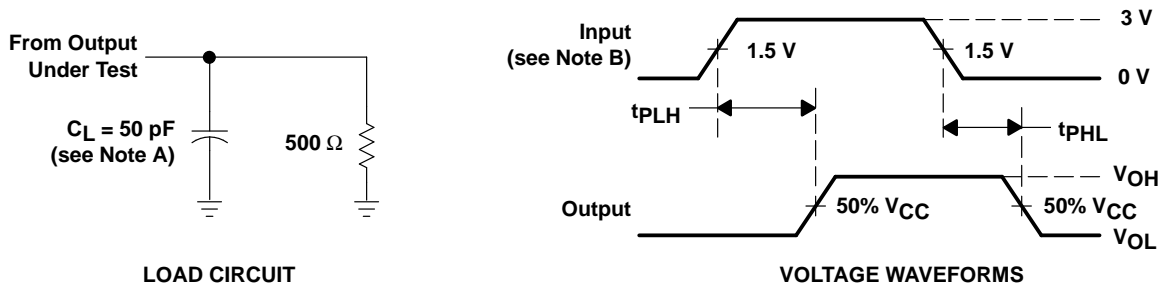
NOTES: A. C_L includes probe and jig capacitance.
   B. Input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, $Z_O = 50\ \Omega$, $t_r = 3\ ns$, $t_f = 3\ ns$.
   C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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